

<b>Notice of References Cited</b>	Application/Control No. 10/796,763	Applicant(s)/Patent Under Reexamination HYNECEK ET AL.
	Examiner A. Sefer	Art Unit 2826

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0178466	09-2004	Merrill et al.	257/440
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

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